

<b>Notice of References Cited</b>	Application/Control No. 10/565,654		Applicant(s)/Patent Under Reexamination TANIKAWA ET AL.	
	Examiner DAQUAN ZHAO		Art Unit 2621	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,091,884	07-2000	Yuen et al.	386/83
*	B	US-5,758,009	05-1998	Hashimoto et al.	386/83
*	C	US-2007/0061843	03-2007	Sano et al.	725/055
*	D	US-6,208,800	03-2001	Katsuyama et al.	386/83
*	E	US-2003/0142958	07-2003	Matsunaga et al.	386/93
*	F	US-2004/0240850	12-2004	Kamio, Hiroyuki	386/095
*	G	US-2004/0086263	05-2004	Arora, Jitesh	386/069
*	H	US-2007/0055980	03-2007	Megeid et al.	725/028
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.